# **STARPOWER**

SEMICONDUCTOR<sup>™</sup>

# GD2400SGT120C3S

**Molding Type Module** 

### 1200V/2400A 1 in one-package

## **General Description**

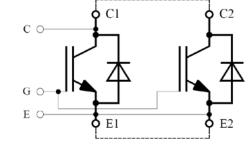
STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as high power converters.

### **Features**

- Low V<sub>CE(sat)</sub> Trench IGBT technology
- 10µs short circuit capability
- $V_{\mbox{\scriptsize CE}(\mbox{\scriptsize sat})}$  with positive temperature coefficient
- Low inductance case •
- Fast & soft reverse recovery anti-parallel FWD
- Isolated copper baseplate using DBC technology

# **Typical Applications**

- **AC Inverter Drives**
- Uninterruptible Power Supply
- Wind Turbines



external connection to be done Equivalent Circuit Schematic

# **Preliminary**

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Symbol	Description	GD2400SGT120C3S	Units
V <sub>CES</sub>	Collector-Emitter Voltage	1200	V
V <sub>GES</sub>	Gate-Emitter Voltage	±20	V
T	Collector Current @ $T_C=25^{\circ}C$	3400	•
I <sub>C</sub>	@ T <sub>C</sub> =80°C	2400	A
I <sub>CM(1)</sub>	Pulsed Collector Current $t_p = 1 \text{ ms}$	4800	Α
$I_{\rm F}$	Diode Continuous Forward Current	2400	Α
I <sub>FM</sub>	Diode Maximum Forward Current	4800	Α
P <sub>D</sub>	Maximum power Dissipation @ $T_j=150^{\circ}C$	9.6	kW
Tj	Maximum Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature Range	-40 to +125	°C
V <sub>ISO</sub>	Isolation Voltage RMS,f=50Hz,t=1min	2500	V
Mounting Torque	Signal Terminal Screw:M4	1.8 to 2.1	
	Power Terminal Screw:M8	8.0 to 10	N.m
	Mounting Screw:M6	4.25 to 5.75	

# Absolute Maximum Ratings $T_C=25$ °C unless otherwise noted

#### Notes:

(1) Repetitive rating: Pulse width limited by max. junction temperature

## Electrical Characteristics of IGBT $T_C=25$ °C unless otherwise noted

#### **Off Characteristics**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V <sub>(BR)CES</sub>	Collector-Emitter Breakdown Voltage	T <sub>j</sub> =25℃	1200			V
I <sub>CES</sub>	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0V,$ $T_j=25^{\circ}C$			5.0	mA
I <sub>GES</sub>	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0V,$ $T_j=25^{\circ}C$			400	nA

#### **On Characteristics**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V <sub>GE(th)</sub>	Gate-Emitter Threshold Voltage	$I_C=96mA, V_{CE}=V_{GE},$ $T_j=25^{\circ}C$	5.0	5.8	6.5	V
N/	Collector to Emitter	$I_{C}=2400A, V_{GE}=15V,$ $T_{j}=25^{\circ}C$		1.70	2.15	V
V <sub>CE(sat)</sub>	Saturation Voltage	$I_{C}$ =2400A,V <sub>GE</sub> =15V, T <sub>j</sub> =125 °C		2.00	2.45	v

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Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$Q_G$	Gate charge	V <sub>GE</sub> =-15+15V		23.0		μC
R <sub>Gint</sub>	Internal Gate Resistor	T <sub>j</sub> =25°C		0.8		Ω
t <sub>d(on)</sub>	Turn-On Delay Time			600		ns
t <sub>r</sub>	Rise Time	V <sub>CC</sub> =600V,I <sub>C</sub> =2400A,		215		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{Gon}=1.2\Omega$ ,		815		ns
t <sub>f</sub>	Fall Time	$R_{Goff}=0.3\Omega$		155		ns
Eon	Turn-On Switching Loss	$V_{GE} = \pm 15V, T_j = 25 ^{\circ}C$		/		mJ
$E_{\rm off}$	Turn-Off Switching Loss			/		mJ
t <sub>d(on)</sub>	Turn-On Delay Time			665		ns
t <sub>r</sub>	Rise Time	V <sub>CC</sub> =600V,I <sub>C</sub> =2400A,		235		ns
$t_{d(off)}$	Turn-Off Delay Time	$R_{Gon}=1.2\Omega$ ,		970		ns
t <sub>f</sub>	Fall Time	$R_{Goff}=0.3\Omega$		185		ns
Eon	Turn-On Switching Loss	$V_{GE} = \pm 15V, T_j = 125$ °C		491		mJ
$E_{\rm off}$	Turn-Off Switching Loss			379		mJ
Cies	Input Capacitance			172		nF
C <sub>oes</sub>	Output Capacitance	V <sub>CE</sub> =25V,f=1MHz,		9.01		nF
C <sub>res</sub>	Reverse Transfer Capacitance	V <sub>GE</sub> =0V		7.81		nF
I <sub>SC</sub>	SC Data	$\begin{array}{l} t_{SC} \leqslant 10 \mu s, V_{GE} = 15 V, \\ T_{j} = 125 ^{\circ} C, V_{CC} = 900 V, \\ V_{CEM} \leqslant 1200 V \end{array}$		9600		А
L <sub>CE</sub>	Stray Inductance			12		nH
R <sub>CC'+EE</sub> ,	Module Lead Resistance, Terminal To Chip			0.19		mΩ

# **Switching Characteristics**

# **Electrical Characteristics of DIODE** $T_C=25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
$V_{\rm F}$	Diode Forward	1 2400 4	Tj=25℃		1.65	2.15	V
	Voltage	I <sub>F</sub> =2400A	T <sub>j</sub> =125℃		1.65	2.15	V
Qr	Deservered Charge		Tj=25℃		240		
	Recovered Charge	I <sub>F</sub> =2400A,	T <sub>j</sub> =125℃		450		μC
т	Reverse Recovery	V <sub>R</sub> =600V,	Tj=25℃		1600		٨
I <sub>RM</sub>	Current	$R_{Gon}=1.2\Omega$ ,	T <sub>j</sub> =125℃		2200		А
E <sub>rec</sub>	Reverse Recovery	V <sub>GE</sub> =-15V	T <sub>j</sub> =25℃		65		mľ
	Energy		Tj=125℃		120		mJ

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# **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case (per IGBT)		13	K/kW
$R_{\theta JC}$	Junction-to-Case (per Diode)		23	K/kW
$R_{\theta CS}$	Case-to-Sink	6		K/kW
	(Conductive grease applied, per Module)	0		N/K VV
Weight	Weight of Module	1500		g

#### GD2400SGT120C3S

#### **IGBT Module**

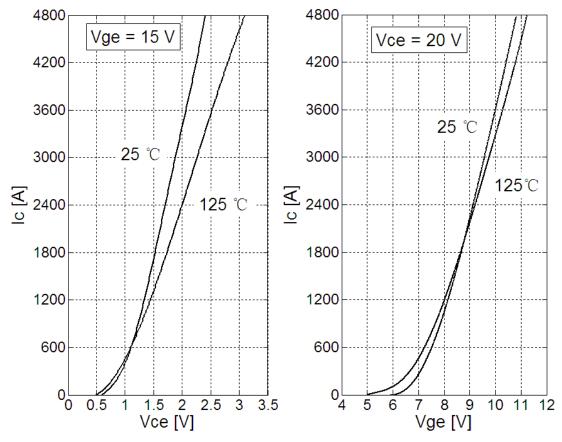
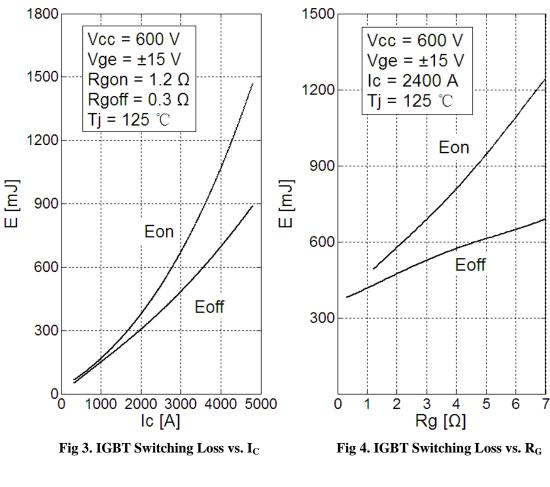


Fig 1. IGBT Typical Output Characteristics Fig 2. IGBT Typical Transfer Characteristics



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#### GD2400SGT120C3S **IGBT Module** 10<sup>2</sup> 5600 4800 Ic,Module 4000 Zthjc [K/kW] 10<sup>1</sup> 3200 lc [A] IGBT 2400 1600 Vge = ±15 V Rgoff = $0.3 \Omega$ 800 10<sup>0</sup> Tj = 125 ℃ 0∟ 0 10<sup>-2</sup> 10<sup>0</sup> 10<sup>-1</sup> 300 600 900 1200 1500 10<sup>1</sup> 10 Vce [V] t [s] Fig 5. RBSOA Fig 6. IGBT Transient Thermal Impedance 4800 150 4000 120 Erec 3200 90 E [mJ] ₹ <sub>2400</sub> 60 1600 Vcc = 600 V **125** ℃ Vge = -15 V 30 Rgon = $1.2 \Omega$ 800 **Tj = 125** ℃ **25** ℃ 0<sup>L</sup> 0 0 1000 2000 3000 4000 5000 ō 1.5 2.5 0.5 2 1 Vf [V] If [A] Fig 7. Diode Typical Forward Characteristics Fig 8. Diode Switching Loss vs. I<sub>F</sub>

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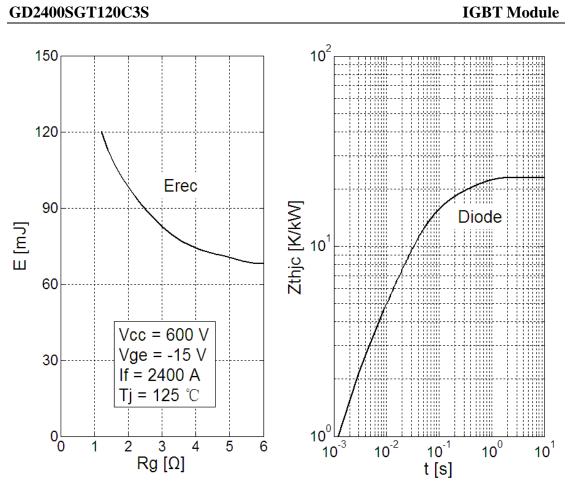
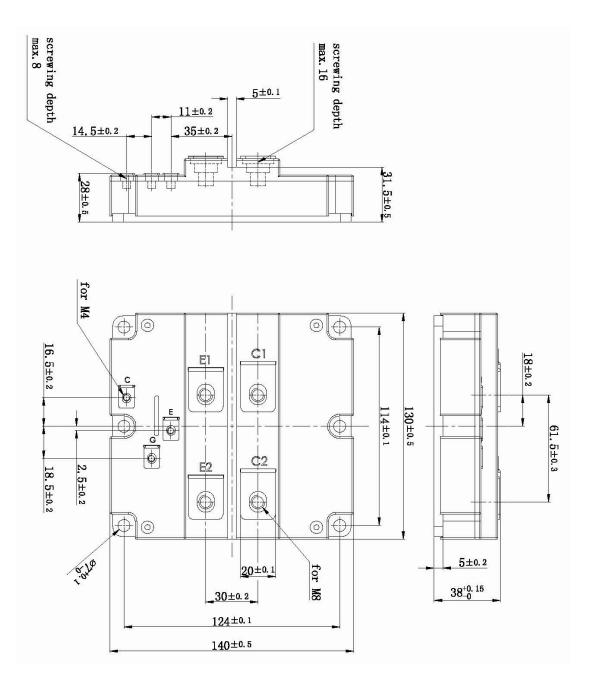


Fig 9. Diode Switching Loss vs. R<sub>G</sub>

Fig 10. Diode Transient Thermal Impedance

# **Package Dimension**

**Dimensions in Millimeters** 



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